



2857

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:
DON MCCORD

Serial No. 09/980,509

Filed: 19 OCTOBER 2001

For: **METHOD AND SYSTEM FOR
WAFER AND DEVICE-LEVEL TESTING
OF AN INTEGRATED CIRCUIT**

§ Docket No. 37802PCT-US

§ Examiner: ASSOUAD, PATRICK J.

§ Art Unit: 2857

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8/15/03

RESPONSE TO RESTRICTION REQUIREMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

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This response is submitted to the Examiner's office action dated August 1, 2003, having a shortened statutory period set to expire September 1, 2003.

CERTIFICATE OF MAILING
37 C.F.R. § 1.8(a)

I hereby certify that this correspondence is being deposited with the United States Postal Service on the below listed date with sufficient postage for first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Date:

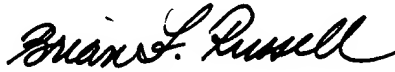
8/8/03

By:

Regina Henneke
Signature

Applicant elects Claims 1-47, without traverse, and withdraws Claims 48-84, without prejudice. Applicant maintains that these claims are in condition for allowance. No extension of time is believed to be required; however, in the event any additional fees are required, please charge such fees or credit any overpayment to **Deposit Account Number 50-0259**.

Respectfully submitted,



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